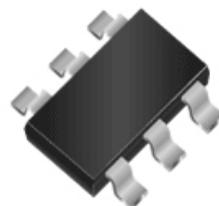


WNMD2166

Dual N-Channel, 20V, 4.0A, Power MOSFET

[Http://www.willsemi.com](http://www.willsemi.com)

| V_{DS} (V) | R_{ds(on)} () | I_D (A) |
|---------------------------|-------------------------------|--------------------------|
| 20 | 0.022@ V _{GS} =4.5V | 4.0 |
| | 0.024@ V _{GS} =3.1V | 2.5 |
| | 0.027@ V _{GS} =2.5V | 2.0 |



Descriptions

The WNMD2166 is N-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent R_{DS(ON)} with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit. Standard Product WNMD2166 is Pb-free.

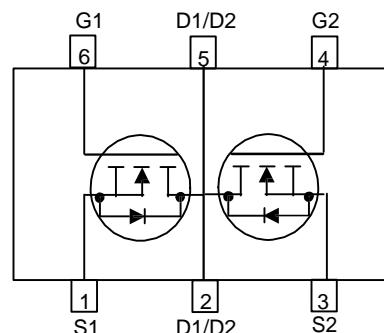
Features

- Trench Technology
- Supper high density cell design
- Excellent ON resistance for higher DC current
- Extremely Low Threshold Voltage
- Small package SOT-23-6L

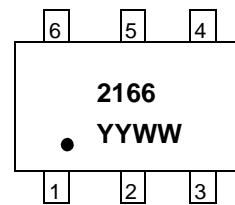
Applications

- Driver for Relay, Solenoid, Motor, LED etc.
- DC-DC converter circuit
- Power Switch
- Load Switch
- Charging

Package



Pin configuration (Top view)



2166 = Device Code
YY = Year
WW = Week

Marking

Order information

| Device | Package | Shipping |
|---------------|----------------|-----------------|
| WNMD2166 | SOT-23-6L | 3000/Reel&Tape |

Absolute Maximum ratings

| Parameter | Symbol | 10 S | Steady State | Unit |
|--|----------------------|----------------|--------------|------|
| Drain-Source Voltage | V _{DS} | +20 | | V |
| Gate-Source Voltage | V _{GS} | ±10 | | |
| Continuous Drain Current ^a | T _A =25°C | I _D | 5.0 | A |
| | T _A =70°C | | 3.8 | |
| Maximum Power Dissipation ^a | T _A =25°C | P _D | 1.1 | W |
| | T _A =70°C | | 0.7 | |
| Continuous Drain Current ^b | T _A =25°C | I _D | 4.0 | A |
| | T _A =70°C | | 3.5 | |
| Maximum Power Dissipation ^b | T _A =25°C | P _D | 0.9 | W |
| | T _A =70°C | | 0.55 | |
| Pulsed Drain Current ^c | I _{DM} | | 25 | A |
| Operating Junction Temperature | T _J | | -55~+150 | °C |
| Lead Temperature | T _L | | 260 | °C |
| Storage Temperature Range | T _{stg} | | -55~+150 | °C |

Thermal resistance ratings

| Parameter | Symbol | Typical | Maximum | Unit |
|---|-----------------|-----------------|---------|------|
| Junction-to-Ambient Thermal Resistance ^a | t = 10 s | R _{JA} | 90 | °C/W |
| | Steady State | | 115 | |
| Junction-to-Ambient Thermal Resistance ^b | t = 10 s | R _{JA} | 105 | °C/W |
| | Steady State | | 138 | |
| Junction-to-Case Thermal Resistance | R _{JC} | 63 | 78 | |

a Surface mounted on FR-4 Board using 1 square inch pad size, 1oz copper

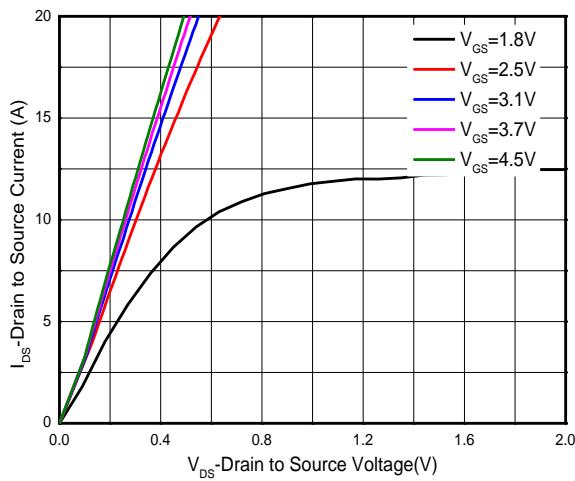
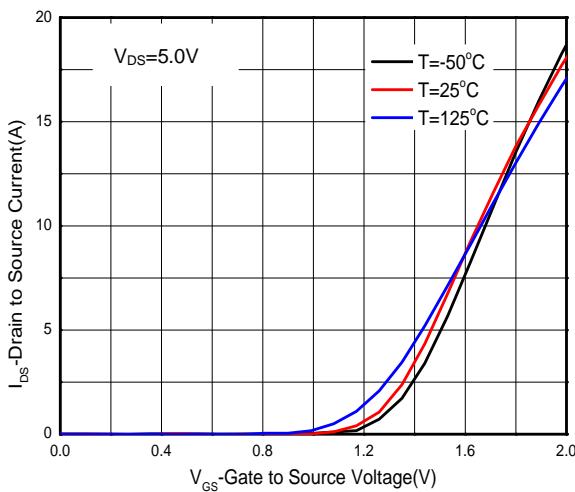
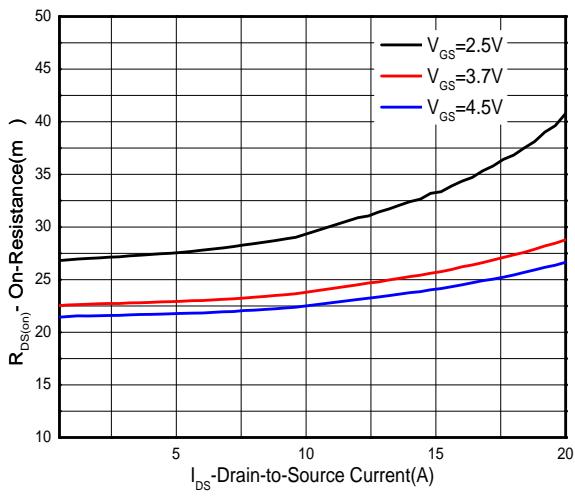
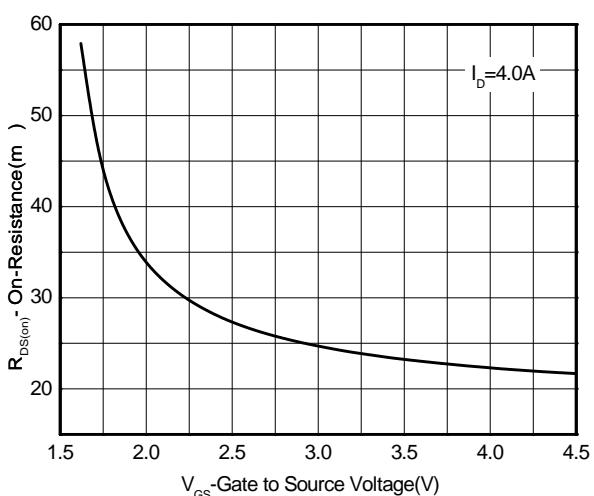
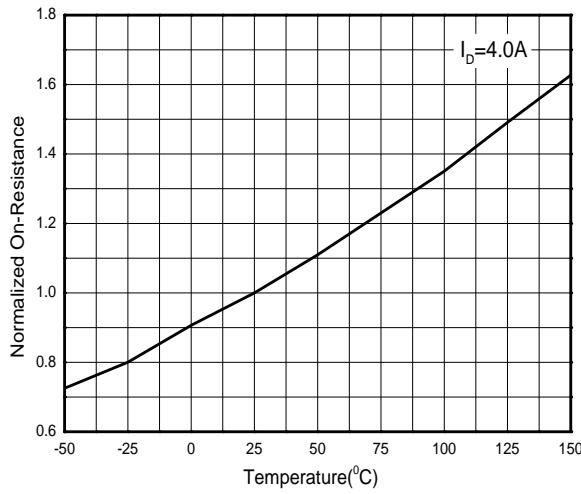
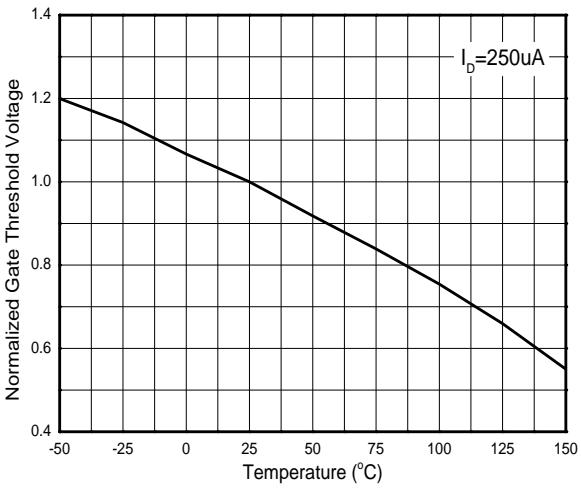
b Surface mounted on FR-4 board using minimum pad size, 1oz copper

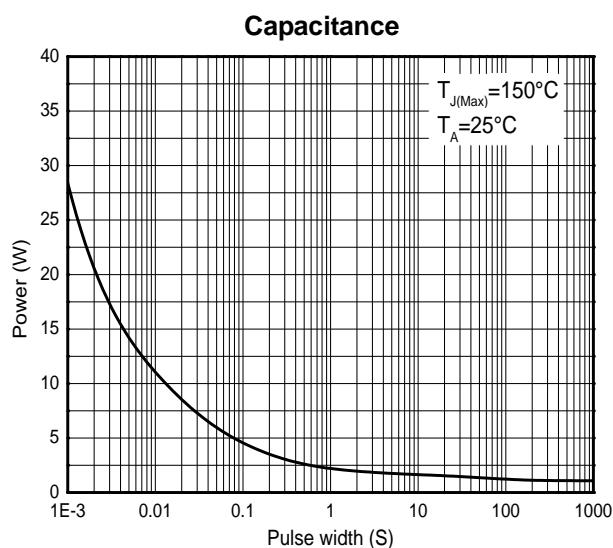
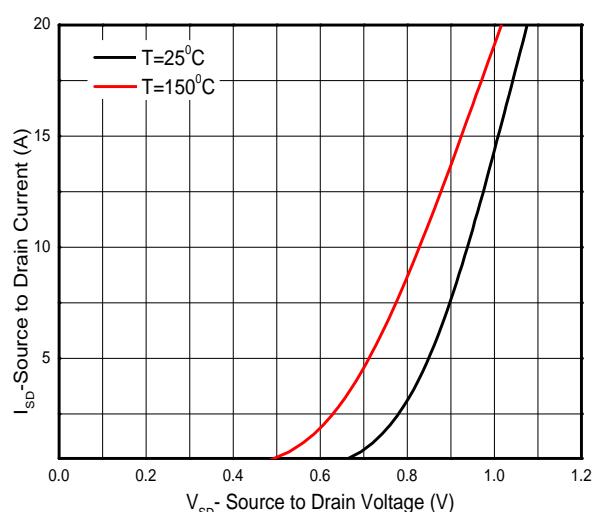
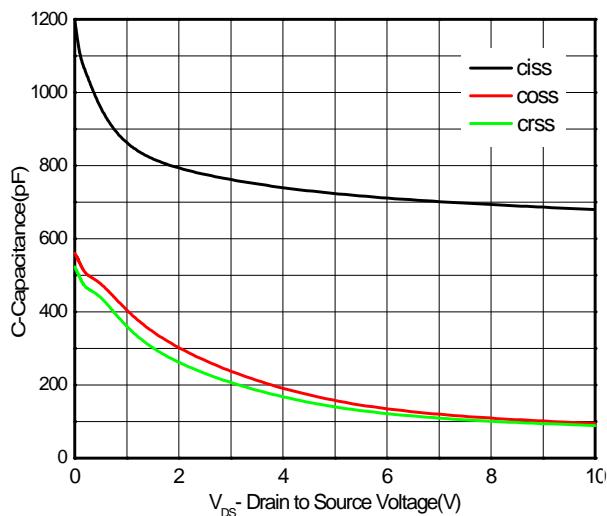
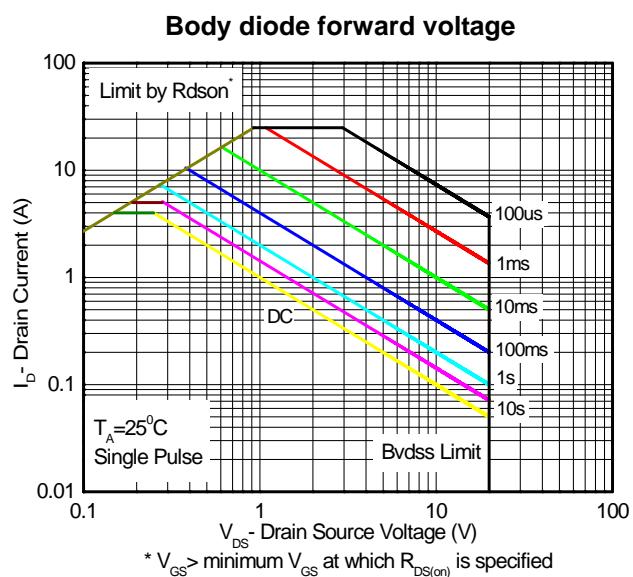
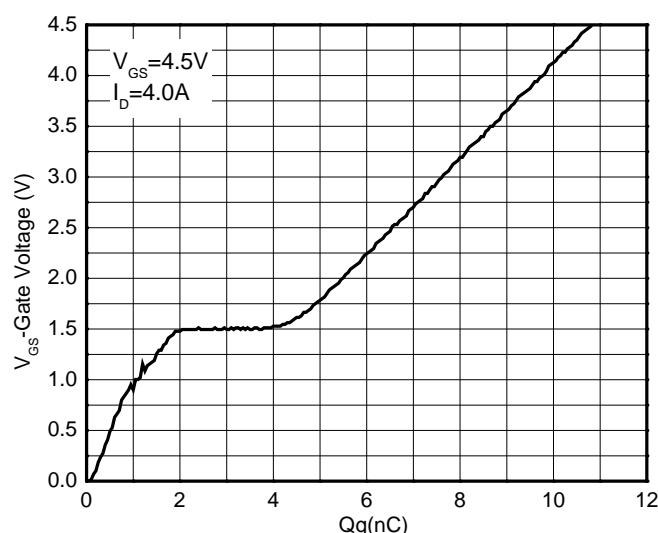
c Pulse width<380μs, Duty Cycle<2%

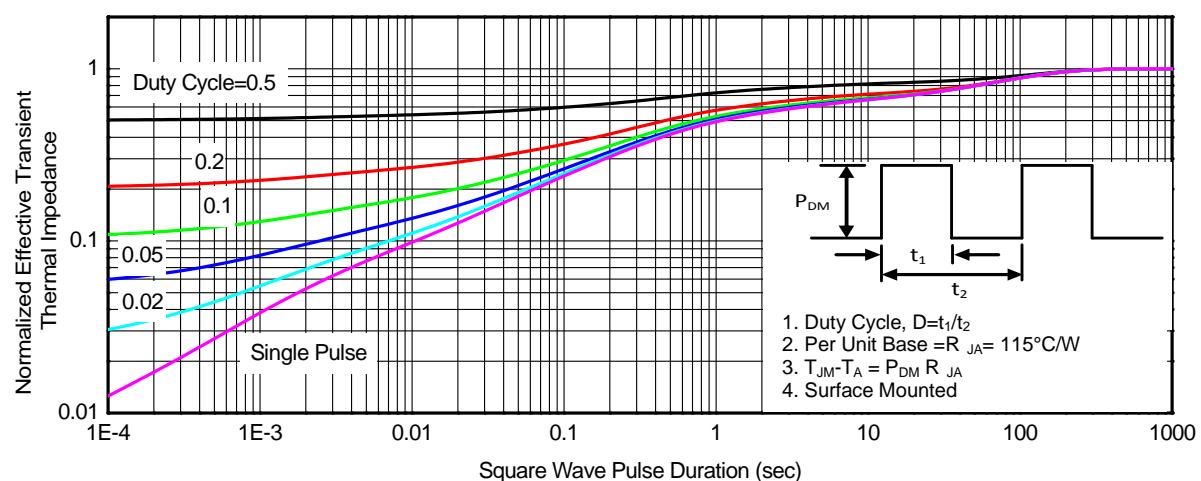
d Maximum junction temperature T_J=150°C.

Electronics Characteristics (Ta=25°C, unless otherwise noted)

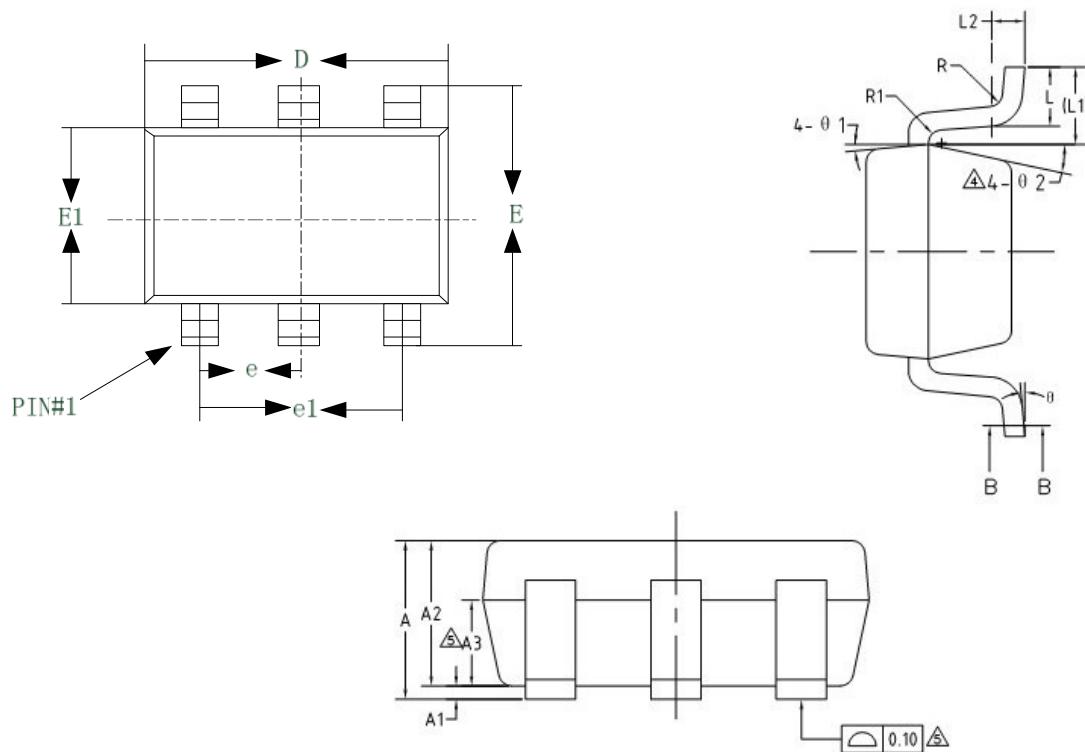
| Parameter | Symbol | Test Conditions | Min | Typ | Max | Unit |
|---|------------------|--|------|------|-----------|---------------|
| OFF CHARACTERISTICS | | | | | | |
| Drain-to-Source Breakdown Voltage | BV_{DSS} | $V_{GS} = 0 \text{ V}, I_D = 250\mu\text{A}$ | 20 | | | V |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = 16\text{V}, V_{GS} = 0\text{V}$ | | | 1 | μA |
| Gate-to-source Leakage Current | I_{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 10 \text{ V}$ | | | ± 100 | nA |
| ON CHARACTERISTICS | | | | | | |
| Gate Threshold Voltage | $V_{GS(TH)}$ | $V_{GS} = V_{DS}, I_D = 250\mu\text{A}$ | 0.45 | 0.75 | 1.0 | V |
| Drain-to-source On-resistance ^{b, c} | $R_{DS(on)}$ | $V_{GS} = 4.5\text{V}, I_D = 4.0\text{A}$ | 15 | 22 | 27 | m |
| | | $V_{GS} = 3.7\text{V}, I_D = 4.0\text{A}$ | 17 | 23 | 30 | |
| | | $V_{GS} = 3.1\text{V}, I_D = 2.5\text{A}$ | 18 | 24 | 35 | |
| | | $V_{GS} = 2.5\text{V}, I_D = 2.0\text{A}$ | 20 | 27 | 37 | |
| Forward Trans conductance | g_{fs} | $V_{DS} = 5.0\text{V}, I_D = 4.0 \text{ A}$ | | 11 | | S |
| CAPACITANCES, CHARGES | | | | | | |
| Input Capacitance | C_{ISS} | $V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz},$ $V_{DS} = 10 \text{ V}$ | | 680 | | pF |
| Output Capacitance | C_{OSS} | | | 95 | | |
| Reverse Transfer Capacitance | C_{RSS} | | | 89 | | |
| Total Gate Charge | $Q_{G(TOT)}$ | $V_{GS} = 4.5 \text{ V},$ $V_{DS} = 10 \text{ V},$ $I_D = 4.0\text{A}$ | | 10.8 | | nC |
| Threshold Gate Charge | $Q_{G(TH)}$ | | | 0.8 | | |
| Gate-to-Source Charge | Q_{GS} | | | 2.3 | | |
| Gate-to-Drain Charge | Q_{GD} | | | 2.5 | | |
| SWITCHING CHARACTERISTICS | | | | | | |
| Turn-On Delay Time | $td(\text{ON})$ | $V_{GS} = 4.5 \text{ V},$ $V_{DS} = 10 \text{ V},$ $I_D = 4.0 \text{ A},$ $R_G=6$ | | 22 | | ns |
| Rise Time | tr | | | 32 | | |
| Turn-Off Delay Time | $td(\text{OFF})$ | | | 60 | | |
| Fall Time | tf | | | 23 | | |
| BODY DIODE CHARACTERISTICS | | | | | | |
| Forward Voltage | V_{SD} | $V_{GS} = 0 \text{ V}, I_S = 1.0\text{A}$ | | 0.78 | 1.50 | V |

Typical Characteristics (Ta=25°C, unless otherwise noted)

Output characteristics

Transfer characteristics

On-Resistance vs. Drain current

On-Resistance vs. Gate-to-Source voltage

On-Resistance vs. Junction temperature

Threshold voltage vs. Temperature


Single pulse power

Safe operating power

Gate charge Characteristics



Transient thermal response (Junction-to-Ambient)

Package outline dimensions
SOT-23-6L


| Symbol | Dimensions in millimeter | | |
|--------|--------------------------|-------|-------|
| | Min. | Typ. | Max. |
| A | - | - | 1.25 |
| A1 | 0 | - | 0.15 |
| A2 | 1.00 | 1.10 | 1.20 |
| A3 | 0.60 | 0.65 | 0.70 |
| b | 0.36 | - | 0.50 |
| b1 | 0.36 | 0.38 | 0.45 |
| c | 0.14 | - | 0.20 |
| c1 | 0.14 | 0.15 | 0.16 |
| D | 2.826 | 2.926 | 3.026 |
| E | 2.60 | 2.80 | 3.00 |
| E1 | 1.526 | 1.626 | 1.726 |
| e | 0.90 | 0.95 | 1.00 |
| e1 | 1.80 | 1.90 | 2.00 |
| L | 0.35 | 0.45 | 0.60 |
| L1 | 0.59REF | | |
| L2 | 0.25BSC | | |
| R | 0.10 | - | - |
| R1 | 0.10 | - | 0.20 |
| Θ | 0° | - | 8° |
| Θ1 | 3° | 5° | 7° |
| Θ2 | 6° | - | 14° |